

**Search Notes**

Application/Control No.

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Examiner

DUC Q. DINH

Applicant(s)/Patent under  
Reexamination

SHON LOW ET AL.

Art Unit

2674

**SEARCHED**

Class	Subclass	Date	Examiner
345	1.1		
	1.2	3/9/2006	DD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH	3/9/2006	DD